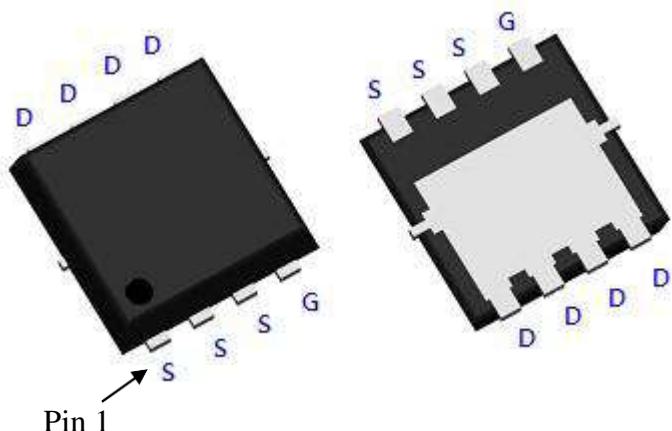


N-Channel Enhancement Mode Power MOSFET

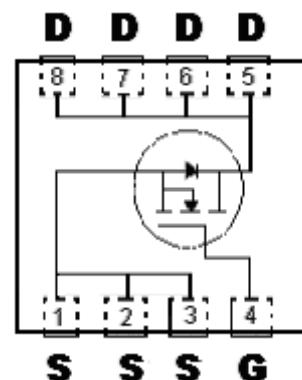
Features:

- Simple drive requirement
- Low on-resistance
- Fast switching speed
- Pb-free lead plating package

DFN3x3



BV _{DSS}	30V
I _D @T _c =25°C, V _{GS} =10V	55A(silicon limit)
I _D @T _c =25°C, V _{GS} =10V	25A(package limit)
I _D @T _A =25°C, V _{GS} =10V	14A
R _{DS(ON)} @V _{GS} =10V, I _D =20A	2.8 mΩ(typ.)
R _{DS(ON)} @V _{GS} =4.5V, I _D =20A	4.0 mΩ(typ.)



G : Gate S : Source D : Drain

Ordering Information

Device	Package	Shipping
KSPRB2D8N03R	DFN3x3 (Pb-free lead plating and halogen-free package)	3000 pcs / Tape & Reel

Absolute Maximum Ratings ($T_a=25^\circ C$)

Parameter	Symbol	Limits	Unit
Drain-Source Voltage	V _{DS}	30	V
Gate-Source Voltage	V _{GS}	± 20	
Continuous Drain Current @ $T_c=25^\circ C$, $V_{GS}=10V$ (silicon limit)	ID	55	A
Continuous Drain Current @ $T_c=100^\circ C$, $V_{GS}=10V$ (silicon limit)		35	
Continuous Drain Current @ $T_c=25^\circ C$, $V_{GS}=10V$ (package limit)		25	
Continuous Drain Current @ $T_A=25^\circ C$, $V_{GS}=10V$		14	
Continuous Drain Current @ $T_A=70^\circ C$, $V_{GS}=10V$		11	
Pulsed Drain Current	I _{DM}	220*1	
Avalanche Current @ $L=0.1mH$	I _{AS}	22	
Avalanche Energy @ $L=0.5mH$	E _{AS}	42	mJ
Total Power Dissipation	P _D	25	W
		10	
		1.8*3	
		1.1*3	
Operating Junction and Storage Temperature Range	T _J , T _{stg}	-55~+150	°C

Thermal Data

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-case, max	R _{θJC}	5.2	°C/W
Thermal Resistance, Junction-to-ambient, max	R _{θJA}	71 *3	

Note : 1. Pulse width limited by maximum junction temperature

2. Duty cycle≤1%

3. Surface mounted on 1 in²copper pad of FR-4 board, t≤10s ; 125°C/W when mounted on minimum copper pad.

Electrical Characteristics ($T_J=25^\circ C$, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS}	30	-	-	V	V _{GS} =0V, I _D =250μA
V _{GS(th)}	1	-	2.5		V _{DS} =V _{GS} , I _D =250μA
I _{GSS}	-	-	±100	nA	V _{GS} =±20V, V _{DS} =0V
I _{DSS}	-	-	1		V _{DS} =24V, V _{GS} =0V
	-	-	5	μA	V _{DS} =24V, V _{GS} =0V, T _J =55°C
R _{DSS(ON)*1}	-	2.8	3.7	mΩ	V _{GS} =10V, I _D =20A
	-	4	5.7		V _{GS} =4.5V, I _D =20A
G _{FS} *1	-	28	-	S	V _{DS} =5V, I _D =10A

Electrical Characteristics(Cont.) ($T_J=25^\circ\text{C}$, unless otherwise specified)

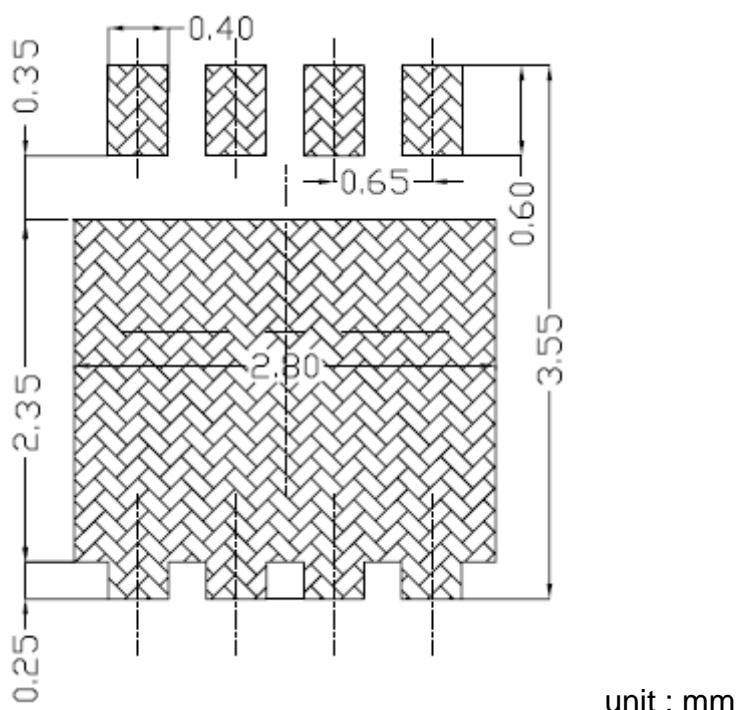
Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Dynamic					
C _{iss}	-	1569	-	pF	V _{DS} =15V, V _{GS} =0V, f=1MHz
C _{oss}	-	1108	-		
C _{rss}	-	125	-		
Q _g *1, 2	-	28	-	nC	V _{DS} =15V, I _D =20A, V _{GS} =10V
Q _{gs} *1, 2	-	5	-		
Q _{gd} *1, 2	-	6	-		
t _{d(ON)} *1, 2	-	14	-		
t _r *1, 2	-	15	-	ns	V _{DS} =15V, I _D =20A, V _{GS} =10V
t _{d(OFF)} *1, 2	-	43	-		R _G =6Ω
t _f *1, 2	-	11	-		
R _g	-	0.9	-	Ω	f=1MHz
Source-Drain Diode					
I _S *1	-	-	20	A	
I _{SM} *3	-	-	80		
V _{SD} *1	-	0.83	1.2	V	I _S =10A, V _{GS} =0V
t _{rr}	-	29.4	-	ns	
Q _{rr}	-	15.8	-	nC	I _F =20A, dI _F /dt=100A/μs

Note : *1.Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

*2.Independent of operating temperature

*3.Pulse width limited by maximum junction temperature.

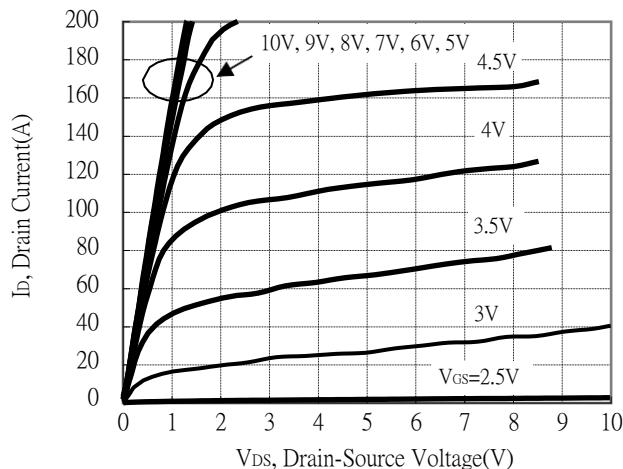
Recommended Soldering Footprint



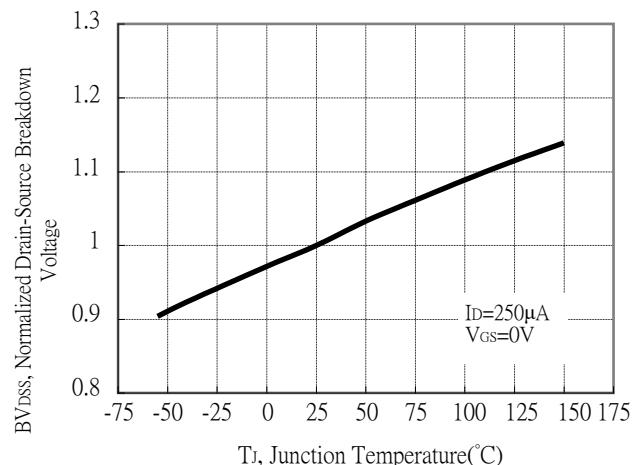
unit : mm

Typical Characteristics

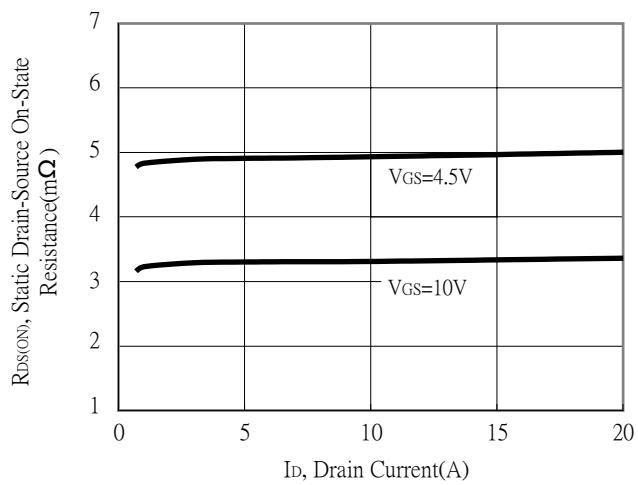
Typical Output Characteristics



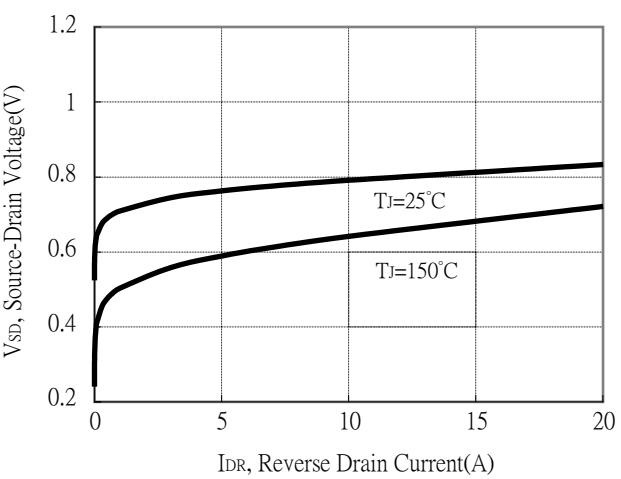
Breakdown Voltage vs Ambient Temperature



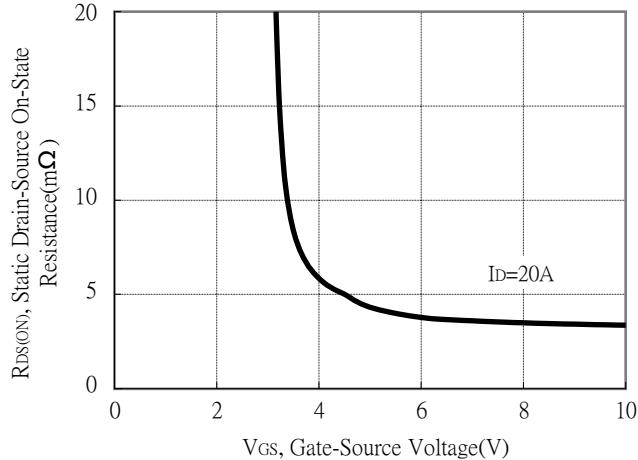
Static Drain-Source On-State resistance vs Drain Current



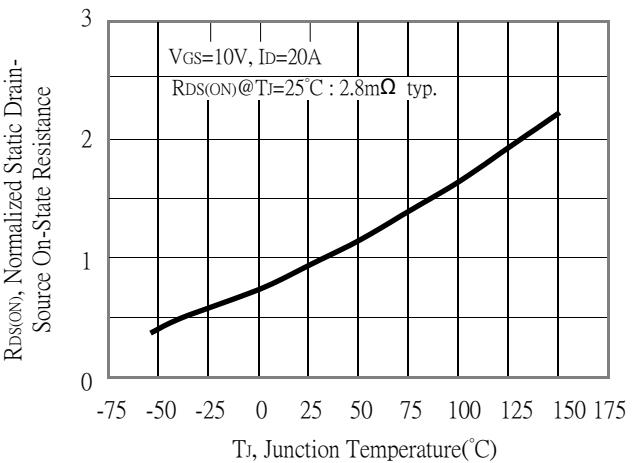
Reverse Drain Current vs Source-Drain Voltage



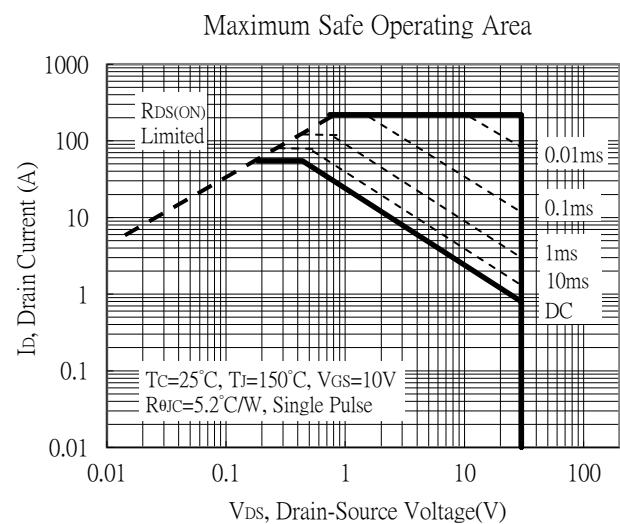
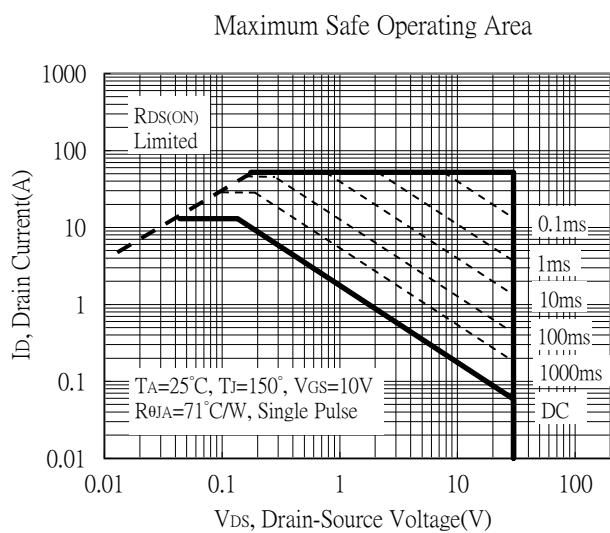
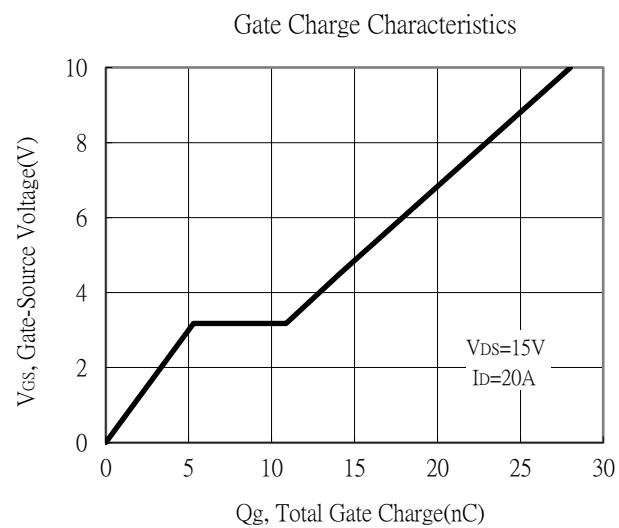
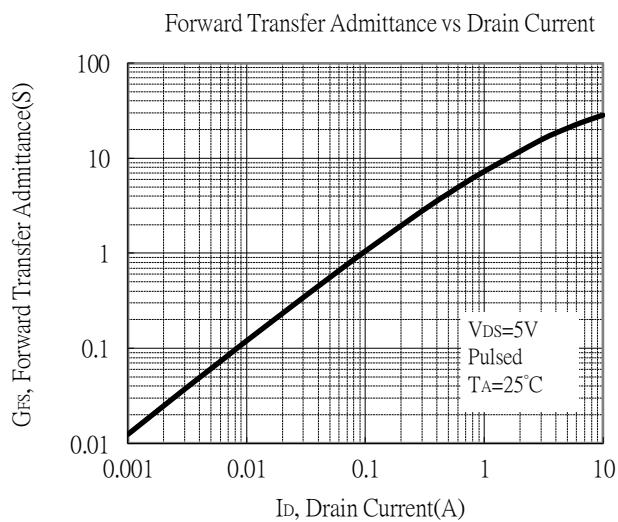
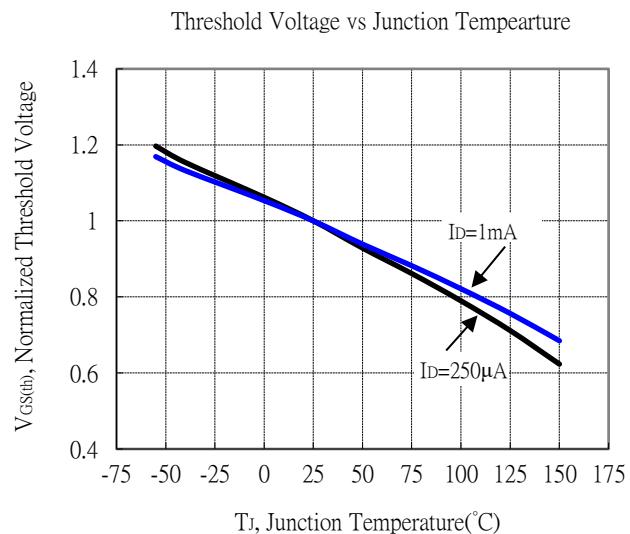
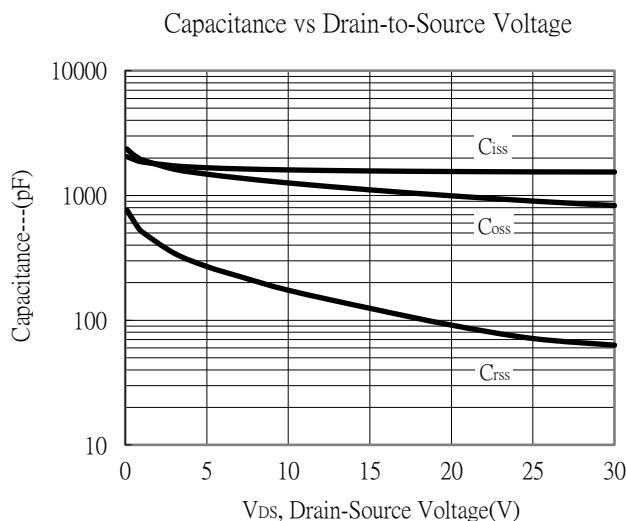
Static Drain-Source On-State Resistance vs Gate-Source Voltage



Drain-Source On-State Resistance vs Junction Temperature

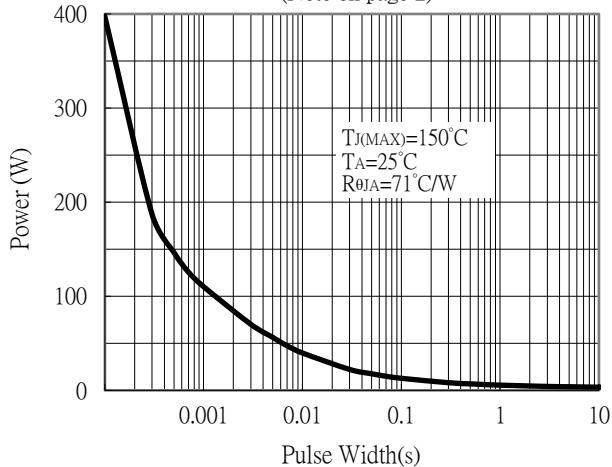


Typical Characteristics(Cont.)

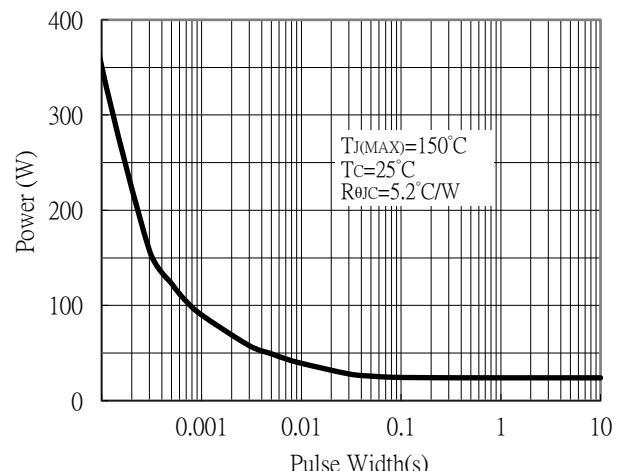


Typical Characteristics(Cont.)

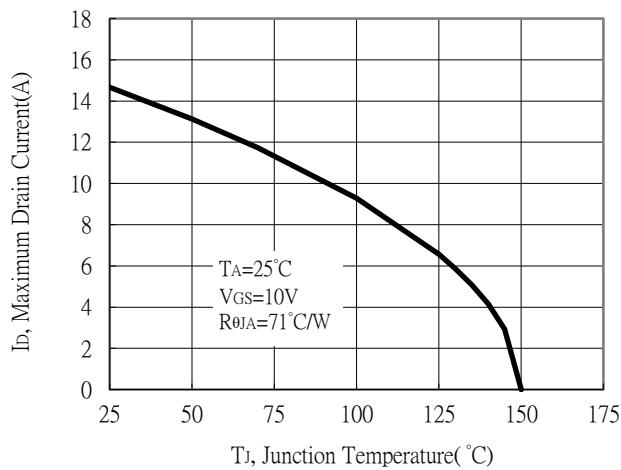
Single Pulse Power Rating, Junction to Ambient
 (Note on page 2)



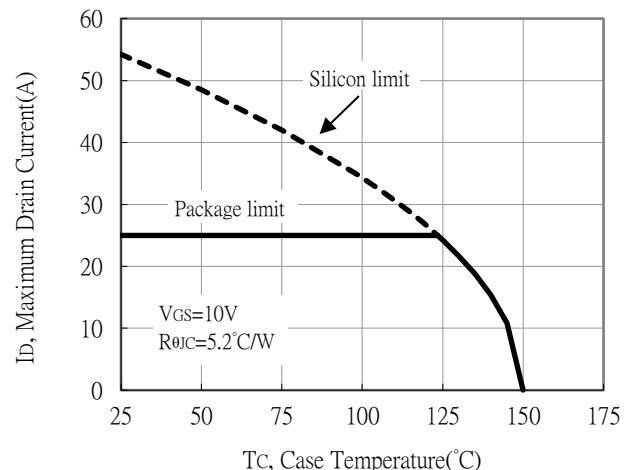
Single Pulse Maximum Power Dissipation



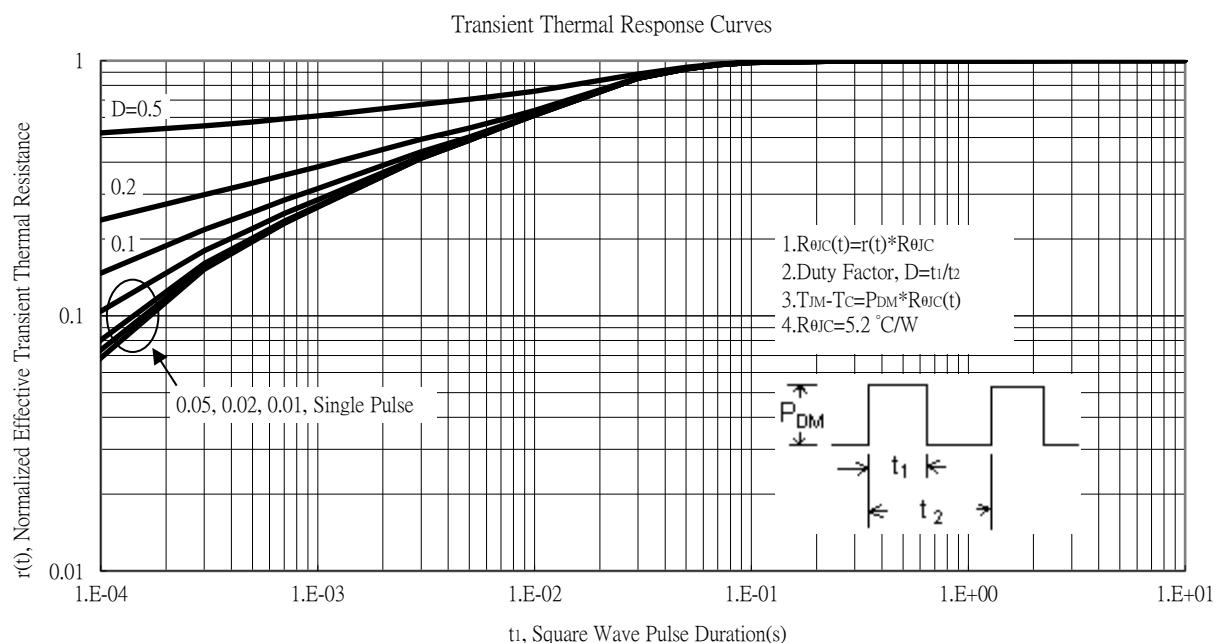
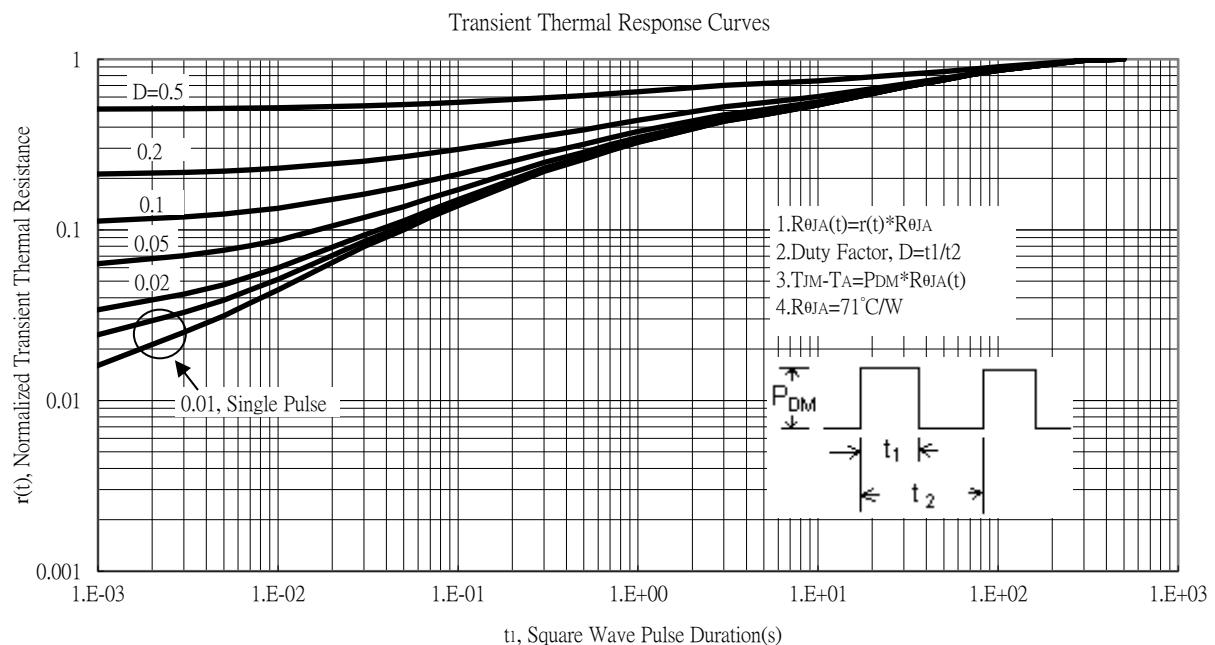
Maximum Drain Current vs Junction Temperature



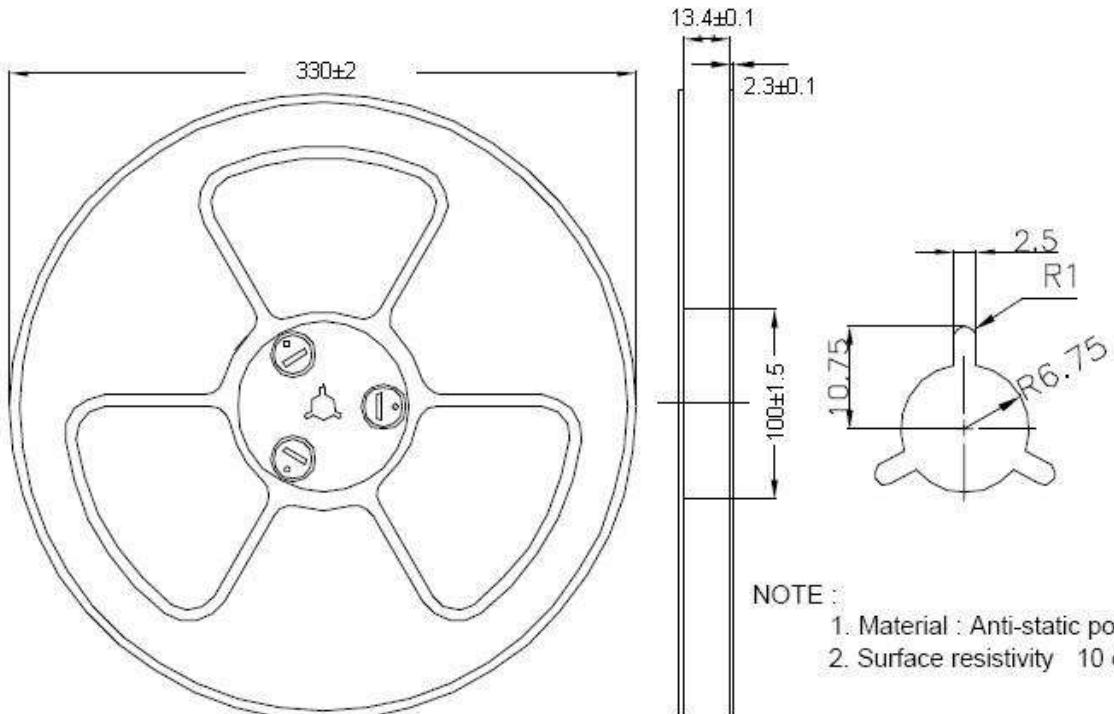
Maximum Drain Current vs Case Temperature



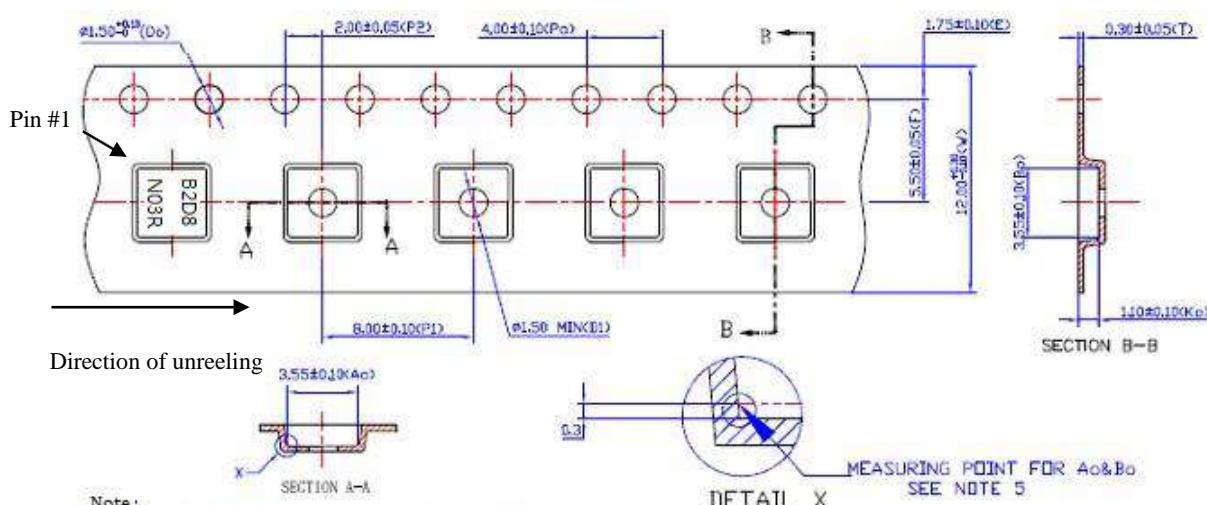
Typical Characteristics(Cont.)



Reel Dimension



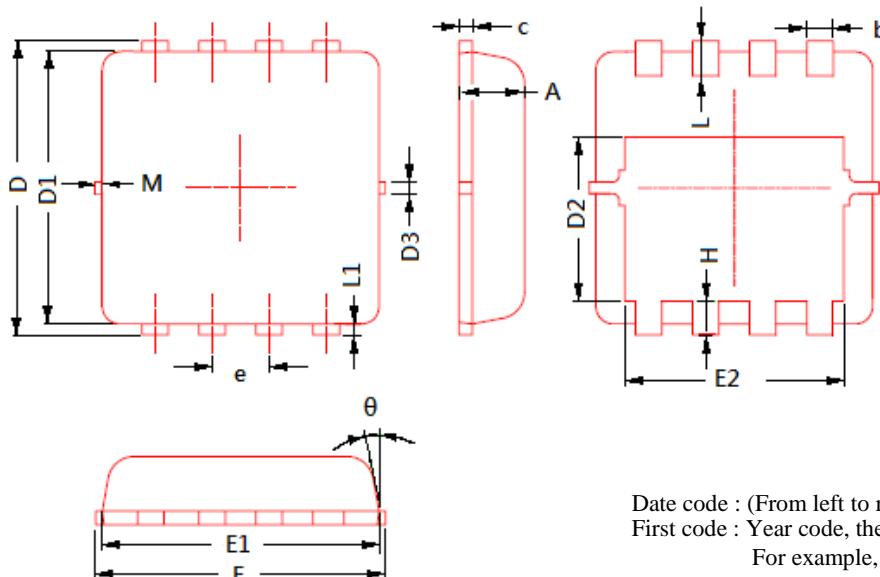
Carrier Tape Dimension



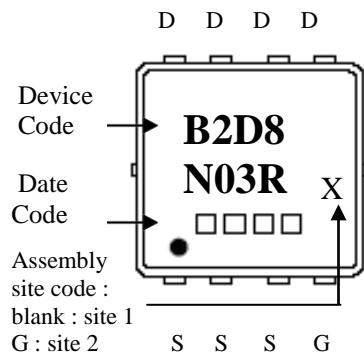
Note :

- 1.10 sprocket hole pitch cumulative tolerance : ±0.2mm.
- 2.Camber : Reference to carrier tape inspection manual.
- 3.Material : black conductive polystyrene.
- 4.All dimensions are in millimeters(unless otherwise specified).
- 5.Ao and Bo measured on a plane 0.3mm above the bottom of the pocket.
- 6.Ko measured from a plane on the inside bottom of the pocket to the top surface of the carrier.
- 7.Pocket position relative to sprocket hole measured as true position of the pocket, not pocket hole.
- 8.Surface resistivity : $1 \times 10^{10} \text{~} 1 \times 10^{11} \text{ ohms/sq}$

DFN3x3 Dimension



Marking:



8-Lead DFN3x3 Plastic Package

Date code : (From left to right)

First code : Year code, the last digit of Christine year.

For example, 2017→7, 2018→8, 2019→9, ..., etc.

Second code : Month code, Jan→A, Feb→B, Mar→C, Apr→D,

May→E, Jun→F, Jul→G, Aug→H, Sep→J, Oct→K,
 Nov→L, Dec→M

Third and fourth codes : production serial number, 01~99

DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.70	0.80	0.028	0.031	E1	3.00	3.20	0.118	0.126
b	0.25	0.35	0.010	0.014	E2	2.39	2.59	0.094	0.102
c	0.10	0.25	0.004	0.010	e	0.65 BSC	0.026 BSC		
D	3.25	3.45	0.128	0.136	H	0.30	0.50	0.012	0.020
D1	3.00	3.20	0.118	0.126	L	0.30	0.50	0.012	0.020
D2	1.78	1.98	0.070	0.078	L1	0.13 TYP	0.005 TYP		
D3	0.13 TYP		0.005 TYP		θ	-	12°	-	12°
E	3.20	3.40	0.126	0.134	M	-	0.15	-	0.006